

# ZXMP10A17GTA-VB Datasheet P-Channel 100-V (D-S) MOSFET

PRODU	PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 100	0.200 at V <sub>GS</sub> = - 10 V	- 3.0	13.2 nC			
- 100	0.230 at V <sub>GS</sub> = - 6 V	- 2.4	13.2110			

## **FEATURES**

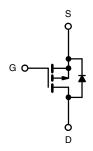
- Trench Power MOSFET
- 100% R<sub>q</sub> and UIS Tested

# RoHS COMPLIANT HALOGEN FREE

## **APPLICATIONS**

- Active Clamp in Intermediate DC/ DC Power Supplies
- H-Bridge High Side Switch for Lighting Application





P-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 100	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	
	T <sub>C</sub> = 25 °C		- 3.0	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1 ,	-2.1	
Continuous Drain Current (1) = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	- 2 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 1.6 <sup>a, b</sup>	Α .
Pulsed Drain Current		I <sub>DM</sub>	- 12	A
Continuous Course Dunin Diada Courset	T <sub>C</sub> = 25 °C		- 4.9	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	- 2.5 <sup>a, b</sup>	
Avalanche Current	. 0.411	I <sub>AS</sub>	- 15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		6.5	
Mayimum Dawar Dissination	T <sub>C</sub> = 70 °C		4.8	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C	1	2 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.

HERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	17	21	C/VV

### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 80  $^{\circ}\text{C/W}.$



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				•		
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 100			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 165		m\//°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		- 6.6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 2		- 4	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Cata Valtana Busin Commant	1	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V		- 1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 8			Α
	В	$V_{GS} = -10 \text{ V}, I_D = -3 \text{ A}$		0.200		-
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(on)}$	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 2 A		0.230		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = 3 A		12		S
Dynamic <sup>b</sup>	-	2	L			
Input Capacitance	C <sub>iss</sub>			819		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 35 V, V <sub>GS</sub> = 0 V, f = 1 MHz		51		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			32		·
Total Gate Charge		$V_{DS} = -50 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -3 \text{ A}$		17.5	32	
	$Q_{g} = \frac{v_{DS} = 33 v_{s} v_{GS} = 13 v_{s} v_{DS} = 37 v_{s}}{v_{GS}}$		13.2	25		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -50 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -3 \text{ A}$		3.4		nC
Gate-Drain Charge	Q <sub>gd</sub>			6.4		
Gate Resistance	R <sub>q</sub>	f = 1 MHz		6.1	9.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	20	
Rise Time	t <sub>r</sub>	$V_{DD} = -50 \text{ V}, R_1 = 25 \Omega$		55	95	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_q = 1 \Omega$		20	40	
Fall Time	t <sub>f</sub>	3		15	30	
Turn-On Delay Time	t <sub>d(on)</sub>			11	18	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -50 \text{ V}, R_i = 25 \Omega$		18	32	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -3 \text{ A}, V_{GEN} = -10 \text{ V}, R_a = 1 \Omega$		32	58	
Fall Time	t <sub>f</sub>	g		20	35	
Drain-Source Body Diode Characterist	•		<u> </u>	<u> </u>		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 13	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 15	Α
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			65	90	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			180	270	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		45		ns
Reverse Recovery Rise Time	t <sub>b</sub>			20		

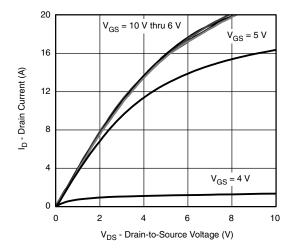
#### Notes:

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

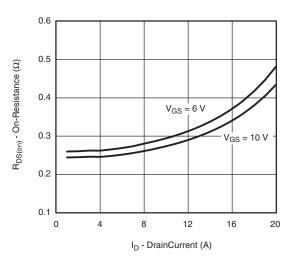
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

b. Guaranteed by design, not subject to production testing.

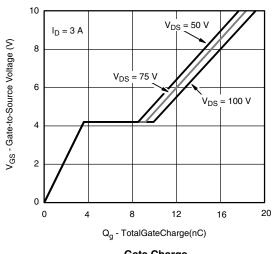




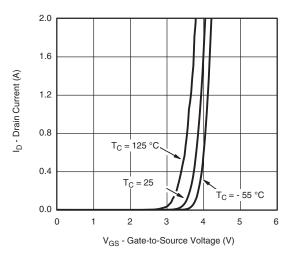
# **Output Characteristics**



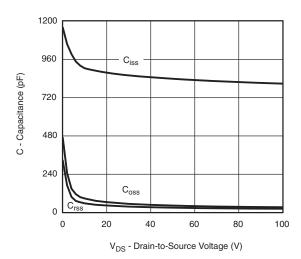
## On-Resistance vs. Drain Current and Gate Voltage



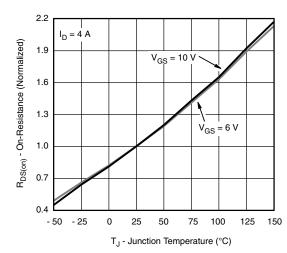
**Gate Charge** 



**Transfer Characteristics** 

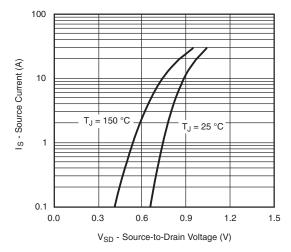


Capacitance

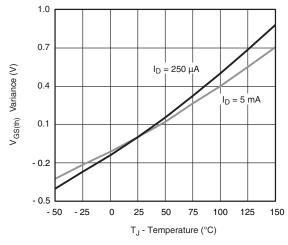


On-Resistance vs. Junction Temperature

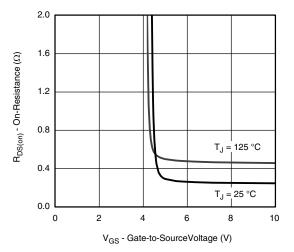




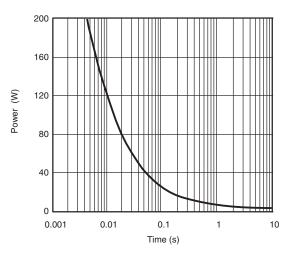
#### Source-Drain Diode Forward Voltage



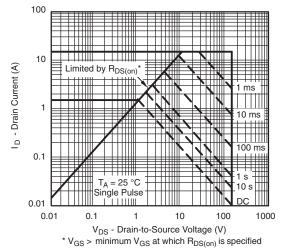
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

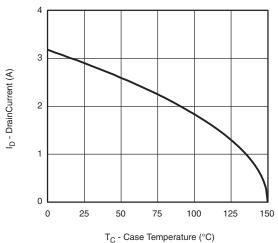


Single Pulse Power, Junction-to-Ambient



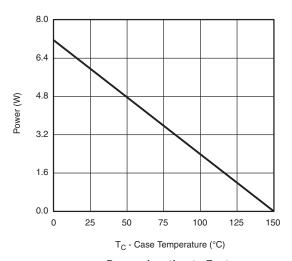
Safe Operating Area, Junction-to-Ambient



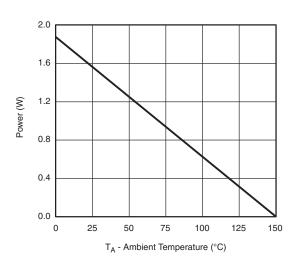


#### (C - care temperature ( )

### **Current Derating\***



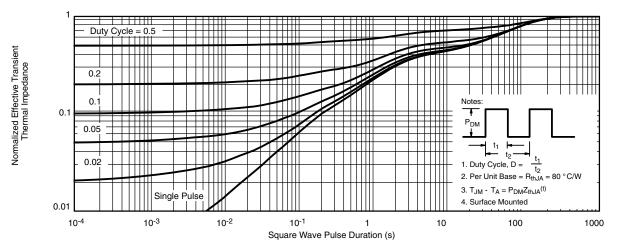




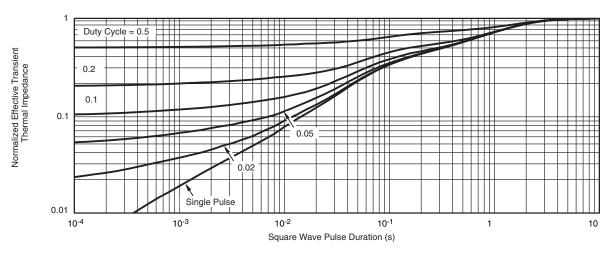
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

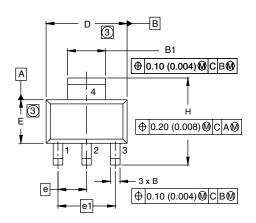


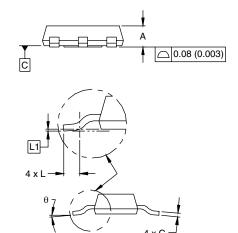
Normalized Thermal Transient Impedance, Junction-to-Foot



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# **SOT-223 (HIGH VOLTAGE)**





DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	1.55	1.80	0.061	0.071
В	0.65	0.85	0.026	0.033
B1	2.95	3.15	0.116	0.124
С	0.25	0.35	0.010	0.014
D	6.30	6.70	0.248	0.264
E	3.30	3.70	0.130	0.146
е	2.30 BSC		0.0905 BSC	
e1	4.60 BSC		0.181 BSC	
Н	6.71	7.29	0.264	0.287
L	0.91	-	0.036	-
L1	0.061 BSC		0.0024	I BSC
θ	-	10'	-	10'

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.



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